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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/689,262	10/20/2003	Min-Chieh Chou	64,600-126	2887

570 7590 12/12/2006

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2005 MARKET STREET, SUITE 2200
PHILADELPHIA, PA 19103

EXAMINER

NGUYEN, TUNG X

ART UNIT	PAPER NUMBER
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2829

DATE MAILED: 12/12/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/689,262

Applicant(s)

CHOU ET AL.

Examiner

Tung X. Nguyen

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 05 October 2006.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 2,3,5,7,13,24,25 and 34 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 2,3,5,7,13,24,25 and 34 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 20 October 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)
Paper No(s)/Mail Date <u>11/06</u> . | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Election/Restrictions

1. Applicant's election without traverse of Group I and species A with claims 2-3, 5, 7, 13, 22, 24-25, and 34 in the reply filed on 10/05/06 is acknowledged.

Claim Objections

2. Claim 25 is objected to because of the following informalities:

"an elongated are body" in line 2 should read --- an elongated arm body---

Appropriate correction is required.

Claim Rejections - 35 USC § 102

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(a) the invention was known or used by others in this country, or patented or described in a printed publication in this or a foreign country, before the invention thereof by the applicant for a patent.

4. Claims 3, 7, 22, and 25 are rejected under 35 U.S.C. 102(a) as being anticipated by Yoshida et al. (u.s.p 6,710,608 heretoeafter Yoshida).

As to claim 7, Yoshida discloses in Figs. 16-20, a probe module comprising: a probe base (116E, 301E, 300E) having a plurality of conductive metal traces (301E, 300E); a plurality of probe pins (3aE) attached to the probe base, each of probe pins comprising an elongated body (3E) wherein at least part of the elongated body is bonded to the plurality of conductive metal traces (301E, and portion after 301E) of the

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probe base; a circuit interconnect device (300E) for connecting the plurality of probe pins to an inspection apparatus (inherent); and a compression arm (112E) attached to the probe base (via 130E) and configured to engage the plurality of probe pins (fig. 20).

As to claim 3, Yoshida discloses in Figs. 16-20, the circuit interconnect device (300E) comprises a plurality of conductive probe circuits (col. 24, lines 45-55) provided on the probe base in electrical contact with the plurality of probe pins (3aE), respectively, and a flexible circuit board (ribbon cable after 300E).

As to claim 22, Yoshida discloses in Figs. 16-20, the flexible circuit board (ribbon cable after 300E) couples the probe pins (3aE) to a testing unit (inherent) via the conductive metal traces (300E).

As to claim 25, Yoshida discloses in Figs. 16-20, the probe pins (3aE) include an elongated (3E) arm body (fig. 17) such that at least a part of the elongated arm body is attached with the probe base (116E).

Claim Rejections - 35 USC § 103

5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

6. Claim 34 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yoshida et al. (u.s.p 6,710,608 heretoeafter Yoshida).

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As to claim 34, Yoshida discloses in Figs. 16-20, the probe module further comprising at least one adjustment screw (130E) provided on the probe base that can be manipulated to adjust the compression arm (112E) against the plurality of probe pins for pressing onto the front ends of the contact pins (3aE). Therefore, it would have been obvious to one having an ordinary skill in the art at the time of the invention was made to recognize when the compression arm with adjust screw (130E) against the plurality of the probe pins for pressing onto the front ends of the contact pins to adjust the contact angle of the probe pins.

7. Claims 2, 5, 24 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yoshida et al. (u.s.p 6,710,608 heretoeafter Yoshida) in view of Farworth (u.s.p 6,362,642 heretoeafter Farworth).

Yoshida discloses in Figs. 16-20, all of the limitations except for a probe pin head is a generally tapered probe pin tip, or semi-spherical probe pin tip. However, Farworth disclose in Figs. 9-10, the pogo pin having a tapered or semi-spherical probe pin tip (14) for easily contacting to a pin of device under test (8). Therefore, it would have been obvious to one having an ordinary skill in the art at the time of the invention was made to modify the probe of Yoshida, and provide the probe with tapered or semi-spherical tip, as taught by Farworth for easily contacting to a pin of device under test during testing (8).

8. Claim 13 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yoshida et al. (u.s.p 6,710,608 heretoeafter Yoshida) in view of Di Stefano (u.s.p 6,426,638 heretoeafter Di Stefano).

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As to claim 13, Yoshida discloses in Figs. 16-20, all of the limitations except for a plurality of probe pins with a tetrahedral probe pin tip. However, Di Stefano discloses in Figs. 3A, a probe pins with a tetrahedral probe pin tip for strongly contact between the probe and device under test. Therefore, it would have been obvious to one having an ordinary skill in the art at the time of the invention was made to modify the probe of Yoshida, and provide the probe with a tetrahedral tip, as taught by Di Stefano for firmly contacting to the device under test during testing.

Conclusion

9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tung X. Nguyen whose telephone number is (571) 272-1967. The examiner can normally be reached on 8:30am-5:00pm M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Ha T. Nguyen can be reached on (571) 272-1678. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

TN

12/09/06



HA TRAN NGUYEN
SUPERVISORY PATENT EXAMINER